

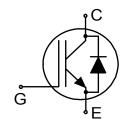
Reverse Conducting IGBT with monolithic body diode

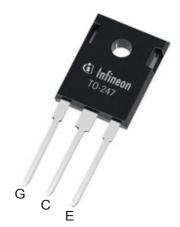
Features:

- · Powerful monolithic body diode with low forward voltage designed for soft commutation
 • TRENCHSTOPTM technology offering:
- very tight parameter distribution
- high ruggedness, temperature stable behavior
- low V_{CEsat}
- easy parallel switching capability due to positive temperature coefficient in V_{CEsat}
- Low EMI
- Qualified according to JESD-022 for target applications
- Pb-free lead plating; RoHS compliant
- Halogen free (according to IEC 61249-2-21)
- Complete product spectrum and PSpice Models: http://www.infineon.com/igbt/

Applications:

- · Induction cooking
- Microwave ovens









Key Performance and Package Parameters

Туре	V CE	I c	V _{CEsat} , T _{vj} =25°C	T _{vjmax}	Marking	Package
IHW30N135R5	1350V	30A	1.65V	175°C	H30PR5	PG-TO247-3



Resonant Switching Series

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Resonant Switching Series

Maximum Ratings

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Parameter	Symbol	Value	Unit
Collector-emitter voltage, <i>T</i> _{vj} ≥ 25°C	V _{CE}	1350	V
DC collector current, limited by T_{vjmax} $T_c = 25$ °C $T_c = 100$ °C	I _C	60.0 30.0	А
Pulsed collector current, t_p limited by T_{vjmax}	I _{Cpuls}	90.0	Α
Non repetitive peak collector current ¹⁾	I _{CSM}	200	Α
Turn off safe operating area $V_{\text{CE}} \le 1350\text{V}, \ T_{\text{vj}} \le 175^{\circ}\text{C}, \ t_{\text{p}} = 1\mu\text{s}$	-	90.0	А
Diode forward current, limited by T_{vjmax} $T_{\text{c}} = 25^{\circ}\text{C}$ $T_{\text{c}} = 100^{\circ}\text{C}$	I _F	60.0 30.0	А
Diode pulsed current, t_p limited by T_{vjmax}	I _{Fpuls}	90.0	Α
Gate-emitter voltage Transient Gate-emitter voltage ($t_p \le 10 \mu s$, $D < 0.010$)	V_{GE}	±20 ±25	V
Power dissipation $T_c = 25^{\circ}\text{C}$ Power dissipation $T_c = 100^{\circ}\text{C}$	P _{tot}	330.0 165.0	W
Operating junction temperature	$T_{ m vj}$	-40+175	°C
Storage temperature	T _{stg}	-55+150	°C
Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s		260	°C
Mounting torque, M3 screw Maximum of mounting processes: 3	М	0.6	Nm

Thermal Resistance

Davamatav	Cymahal	Canditions	Value			11:4:4
Parameter	Symbol	Conditions	min.	min. typ.	max.	Unit
R _{th} Characteristics				•		
IGBT thermal resistance, junction - case	R _{th(j-c)}		-	-	0.45	K/W
Diode thermal resistance, junction - case	R _{th(j-c)}		-	-	0.45	K/W
Thermal resistance junction - ambient	R _{th(j-a)}		-	-	40	K/W



Electrical Characteristic, at T_{vj} = 25°C, unless otherwise specified

Bananatan	0	0	Value			Unit
Parameter	Symbol	Symbol Conditions		typ.	max.	
Static Characteristic			•	•		
Collector-emitter breakdown voltage	V _{(BR)CES}	$V_{\rm GE} = 0 \text{V}, I_{\rm C} = 0.50 \text{mA}$	1350	-	-	V
Collector-emitter saturation voltage	V _{CEsat}	$V_{GE} = 15.0V, I_{C} = 30.0A$ $T_{Vj} = 25^{\circ}C$ $T_{Vj} = 125^{\circ}C$ $T_{Vj} = 175^{\circ}C$	- - -	1.65 1.95 2.05	1.95 - -	V
Diode forward voltage	V _F	$V_{GE} = 0V, I_F = 30.0A$ $T_{vj} = 25^{\circ}C$ $T_{vj} = 125^{\circ}C$ $T_{vj} = 175^{\circ}C$	- - -	1.85 2.10 2.25	2.05	V
Gate-emitter threshold voltage	$V_{GE(th)}$	$I_{\rm C} = 0.75 {\rm mA}, \ V_{\rm CE} = V_{\rm GE}$	5.1	5.8	6.4	V
Zero gate voltage collector current	I _{CES}	$V_{\text{CE}} = 1350 \text{V}, \ V_{\text{GE}} = 0 \text{V}$ $T_{\text{vj}} = 25^{\circ}\text{C}$ $T_{\text{vj}} = 175^{\circ}\text{C}$		- 630	100	μA
Gate-emitter leakage current	I _{GES}	$V_{CE} = 0V, V_{GE} = 20V$	-	-	100	nA
Transconductance	g fs	$V_{CE} = 20V, I_{C} = 30.0A$	-	23.0	-	S
Integrated gate resistor	r _G			none		Ω

Electrical Characteristic, at T_{vj} = 25°C, unless otherwise specified

Barrantan	0	O and the same	Value		11	
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Dynamic Characteristic			•			
Input capacitance	Cies		-	1810	-	
Output capacitance	Coes	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$	-	50	-	pF
Reverse transfer capacitance	Cres		-	40	-	
Gate charge	Q_{G}	$V_{\text{CC}} = 1080 \text{V}, I_{\text{C}} = 30.0 \text{A}, V_{\text{GE}} = 15 \text{V}$	-	235.0	-	nC
Internal emitter inductance measured 5mm (0.197 in.) from case	LE		-	13.0	-	nH

Switching Characteristic, Inductive Load

Developer	Comphal	Canditions	Value			Unit
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
IGBT Characteristic, at $T_{vj} = 25^{\circ}$ C	;					
Turn-off delay time	$t_{\sf d(off)}$	$T_{\rm vi} = 25^{\circ}{\rm C},$	-	310	-	ns
Fall time	t _f	$V_{\rm CC} = 600 \text{V}, I_{\rm C} = 30.0 \text{A},$	-	120	-	ns
Turn-off energy	E _{off}	$V_{\rm GE}$ = 0.0/15.0V, $R_{\rm G(on)}$ = 10.0 Ω , $R_{\rm G(off)}$ = 10.0 Ω , $L\sigma$ = 175nH, $C\sigma$ = 40pF $L\sigma$, $C\sigma$ from Fig. E Energy losses include "tail" and diode reverse recovery.	-	1.40	-	mJ
Turn-off energy, soft switching	E _{off}	<i>dv/dt</i> = 200.0V/μs	-	0.17	-	mJ



Resonant Switching Series

Switching Characteristic, Inductive Load

Davamatan	Combal	Conditions	Value		Unit	
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
IGBT Characteristic, at $T_{vj} = 175^{\circ}$	C					
Turn-off delay time	$t_{\sf d(off)}$	T _{vi} = 175°C,	-	385	-	ns
Fall time	t _f	$V_{\rm CC} = 600 \text{V}, I_{\rm C} = 30.0 \text{A},$	-	295	-	ns
Turn-off energy	E _{off}	V_{GE} = 0.0/15.0V, $R_{\text{G(on)}}$ = 10.0 Ω , $R_{\text{G(off)}}$ = 10.0 Ω , $L\sigma$ = 175nH, $C\sigma$ = 40pF $L\sigma$, $C\sigma$ from Fig. E Energy losses include "tail" and diode reverse recovery.	-	2.70	-	mJ
Turn-off energy, soft switching	E off	<i>dv/dt</i> = 200.0V/μs	-	0.57	-	mJ

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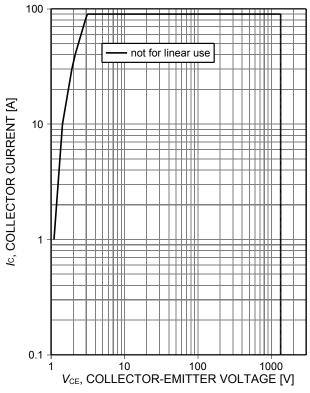


Figure 1. Forward bias safe operating area $(D=0, T_C=25^{\circ}C, T_{vj}\le175^{\circ}C; V_{GE}=15V; tp=1\mu s)$

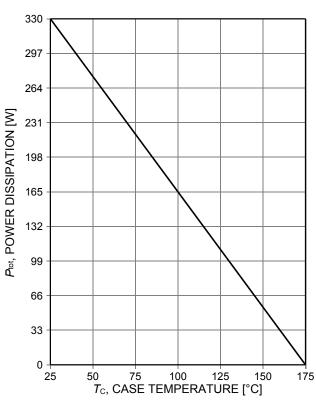


Figure 2. Power dissipation as a function of case temperature (*T*_v≤175°C)

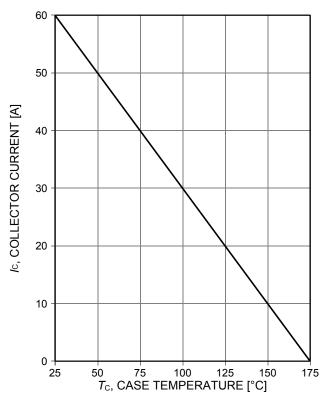


Figure 3. Collector current as a function of case temperature $(V_{GE} \ge 15V, T_{vj} \le 175^{\circ}C)$

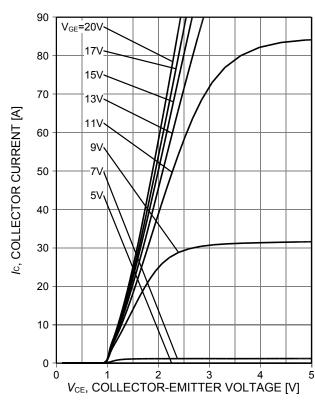


Figure 4. **Typical output characteristic** (T_{vj} =25°C)

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Resonant Switching Series

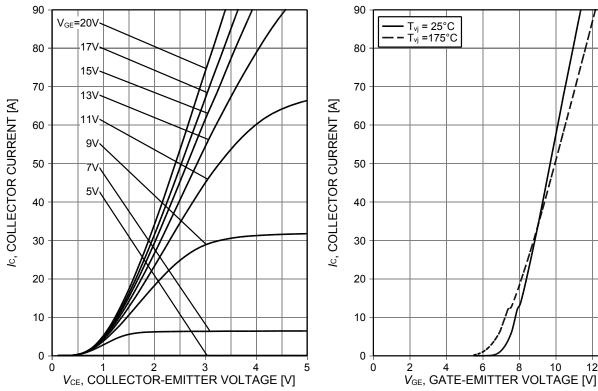


Figure 5. **Typical output characteristic** $(T_{vi}=175^{\circ}\text{C})$

Figure 6. **Typical transfer characteristic** $(V_{CE}=20V)$

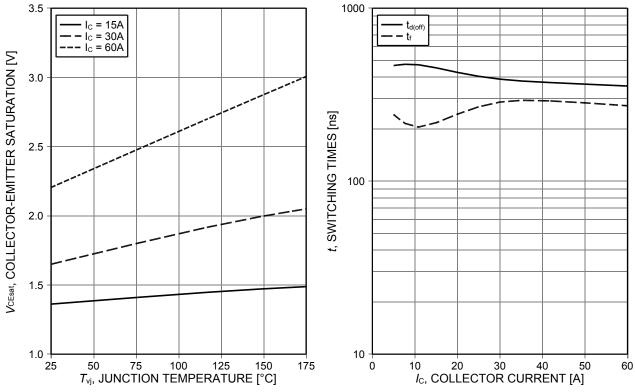


Figure 7. Typical collector-emitter saturation voltage as a function of junction temperature (V_{GE} =15V) Figure 8. Typical switching times as a function of collector current (inductive load, T_{vj} =175°C, V_{CE} =600V,

(inductive load, $I_{V_j}=175^{\circ}\text{C}$, $V_{CE}=600\text{V}$, $V_{GE}=0/15\text{V}$, $I_{GE}=10\Omega$, Dynamic test circuit in Figure E)

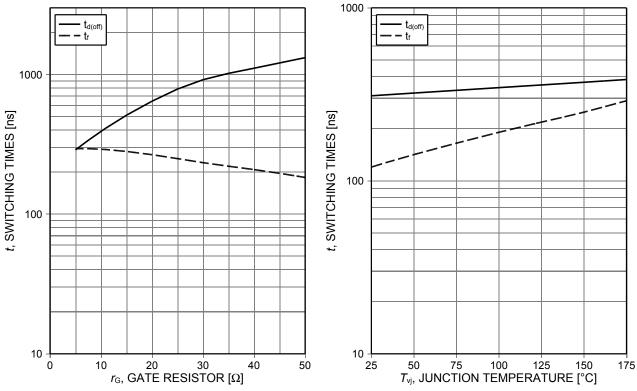


Figure 9. Typical switching times as a function of gate (inductive load, $T_{\rm vj}$ =175°C, $V_{\rm CE}$ =600V, $V_{\rm GE}$ =0/15V, $I_{\rm C}$ =30A, Dynamic test circuit in

Figure E)

Figure 10. Typical switching times as a function of junction temperature (inductive load, V_{CE} =600V, V_{GE} =0/15V, $I_{\rm C}$ =30A, $r_{\rm G}$ =10 Ω , Dynamic test circuit in Figure E) 6

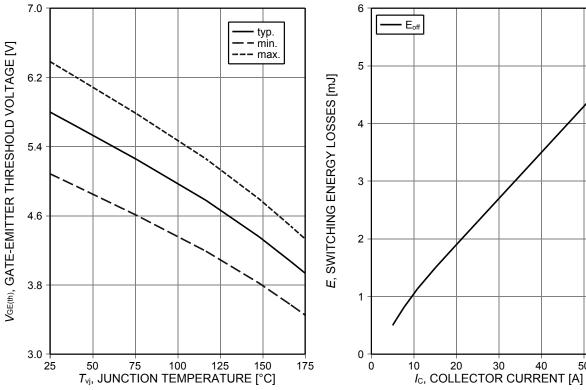


Figure 11. Gate-emitter threshold voltage as a function Figure 12. Typical switching energy losses as a of junction temperature $(I_{\rm C}=0.75{\rm mA})$

function of collector current (inductive load, T_{vj}=175°C, V_{CE}=600V, $V_{\rm GE}$ =0/15V, $r_{\rm G}$ =10 Ω , Dynamic test circuit in

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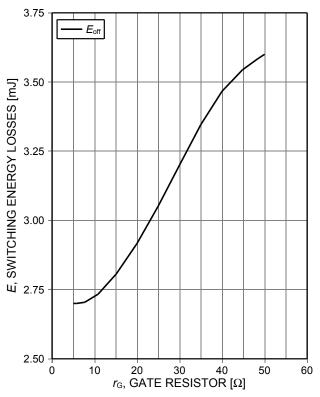


Figure 13. Typical switching energy losses as a function of gate resistor (inductive load, $T_{\rm vj}$ =175°C, $V_{\rm CE}$ =600V, $V_{\rm GE}$ =0/15V, $I_{\rm C}$ =30A, Dynamic test circuit in Figure E)

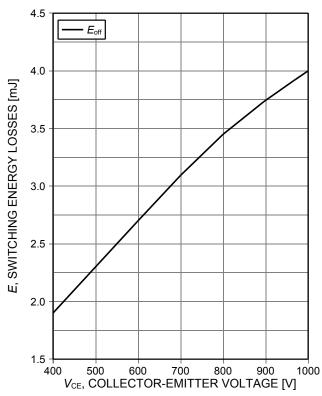


Figure 15. Typical switching energy losses as a function of collector emitter voltage (inductive load, $T_{\rm vj}$ =175°C, $V_{\rm GE}$ =0/15V, $I_{\rm C}$ =30A, $I_{\rm G}$ =10 Ω , Dynamic test circuit in Figure E)

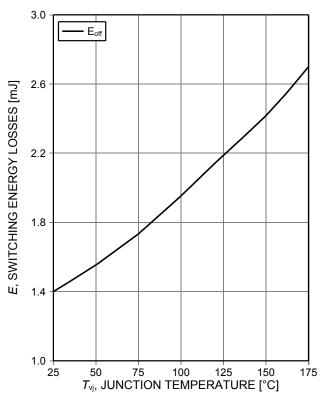


Figure 14. Typical switching energy losses as a function of junction temperature (inductive load, V_{CE} =600V, V_{GE} =0/15V, I_{C} =30A, I_{G} =10 Ω , Dynamic test circuit in Figure E)

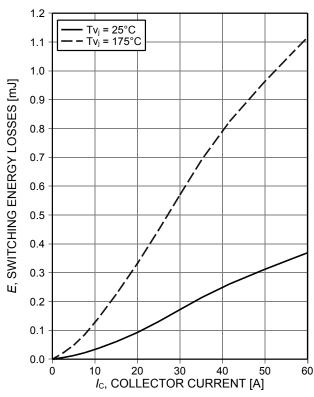


Figure 16. Typical turn off switching energy loss for soft switching (inductive load, V_{CE} =600V, V_{GE} =0/15V, r_{G} =10 Ω , Dynamic test circuit in Figure E)

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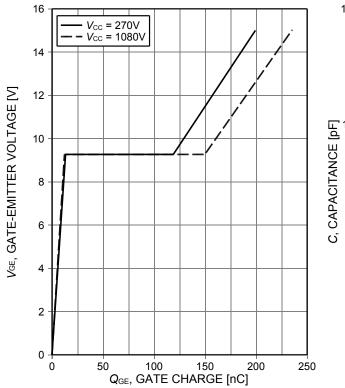


Figure 17. **Typical gate charge** $(I_c=30A)$

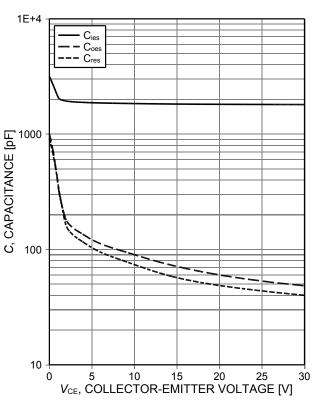


Figure 18. Typical capacitance as a function of collector-emitter voltage (V_{GE}=0V, f=1MHz)

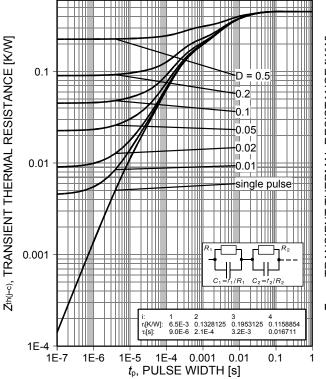


Figure 19. **IGBT transient thermal resistance** $(D=t_p/T)$

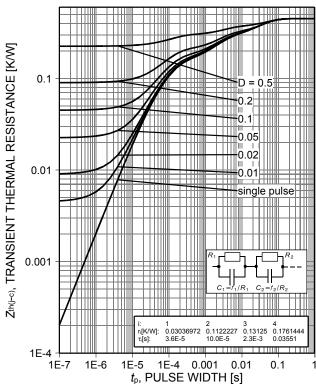


Figure 20. Diode transient thermal impedance as a function of pulse width $(D=t_p/T)$



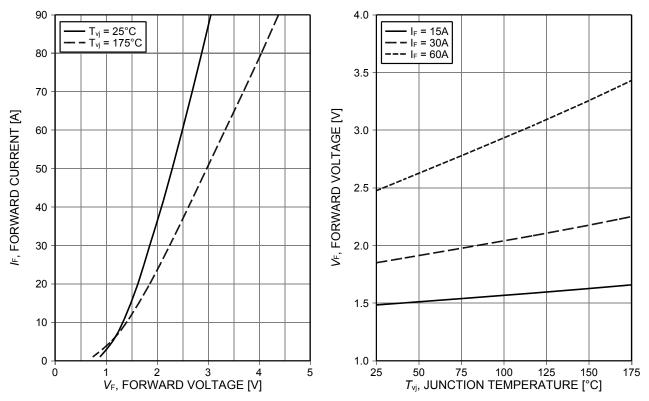
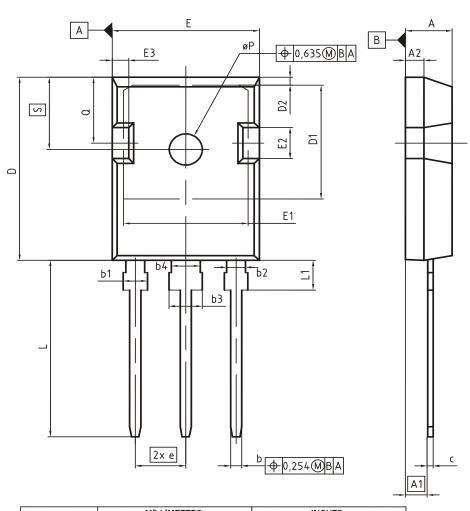


Figure 21. Typical diode forward current as a function of forward voltage

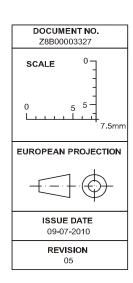
Figure 22. **Typical diode forward voltage as a function of junction temperature**



Package Drawing PG-TO247-3



DIM	MILLIN	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.83	5.21	0.190	0.205	
A1	2.27	2.54	0.089	0.100	
A2	1.85	2.16	0.073	0.085	
b	1.07	1.33	0.042	0.052	
b1	1.90	2.41	0.075	0.095	
b2	1.90	2.16	0.075	0.085	
b3	2.87	3.38	0.113	0.133	
b4	2.87	3.13	0.113	0.123	
С	0.55	0.68	0.022	0.027	
D	20.80	21.10	0.819	0.831	
D1	16.25	17.65	0.640	0.695	
D2	0.95	1.35	0.037	0.053	
Е	15.70	16.13	0.618	0.635	
E1	13.10	14.15	0.516	0.557	
E2	3.68	5.10	0.145	0.201	
E3	1.00	2.60	0.039	0.102	
е	5.44 (BSC) 0.214 (BSC				
N		3	3		
L	19.80	20.32	0.780	0.800	
L1	4.10	4.47	0.161	0.176	
øΡ	3.50	3.70	0.138	0.146	
Q	5.49	6.00	0.216	0.236	
S	6.04	6.30	0.238	0.248	





Testing Conditions

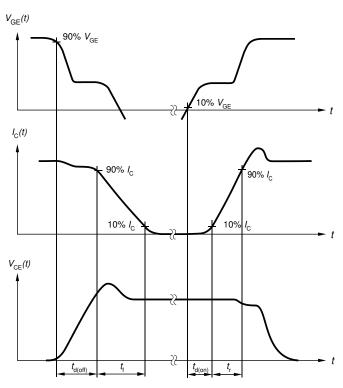


Figure A. Definition of switching times

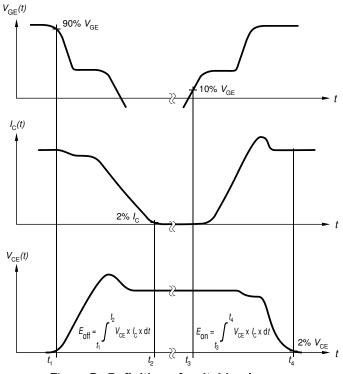


Figure B. Definition of switching losses

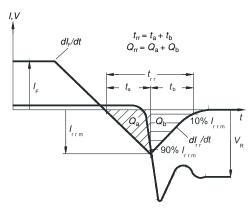


Figure C. **Definition of diode switching** characteristics

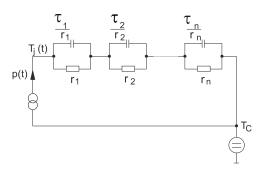


Figure D. Thermal equivalent circuit

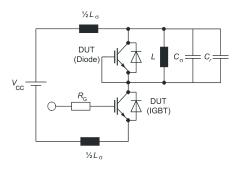


Figure E. Dynamic test circuit Parasitic inductance L_{σ} , parasitic capacitor C_{σ} , relief capacitor C_{r} , (only for ZVT switching)



Resonant Switching Series

Revision History

IHW30N135R5

Revision: 2019-09-20, Rev. 2.3

Previous Revision						
Revision	Date	Subjects (major changes since last revision)				
2.1	2018-04-17	1				
2.2	2018-09-19	Added thermal network on Fig.19 & 20				
2.3	2019-09-20	additional parameter in maximum ratings table: non repetitive peak collector current				

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